

Table 1. ED-XRF excitation conditions and minimum determination limits (MDL) for individual elements given as filter concentrations (ng cm^{-2}) and equivalent seawater concentrations (nM) for the average sample filtration volume of 8 L.

Analyte	Limits of Detection (ng cm^{-2}) (nM)		Excitation conditions, 1° X-ray filter, Voltage, and Current
Mg	16.61	1.06	Low Za, Thin graphite, 10 kV, 1.98 mA
Al	9.4	0.54	
Si	4.61	0.25	
P	2.01	0.10	
S	9.01	0.44	Low Zb, Thick graphite, 12 kV, 1.98 mA
Cl	4.40	0.19	
K	3.15	0.12	
Ca	3.99	0.15	
Ti	2.52	0.08	Mid Za, Thin Pd, 30 kV, 1.66 mA
V	2.41	0.07	
Cr	1.39	0.04	
Mn	1.27	0.04	
Fe	0.95	0.03	Mid Zb, Thick Pd, 50 kV, 1 mA
Ni	0.77	0.02	
Cu	1.25	0.03	
Zn	1.28	0.03	
As	1.39	0.03	
Br	1.42	0.03	
Sr	1.98	0.04	
Pb	1.58	0.01	